Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,303	KADAKIA ET AL.	
Examiner	Art Unit	
DANHCLE	2617	

SEARCHED						
Class	Subclass	Date	Examiner			
455	456.3	10/25/05	DCL			
	456.5					
	456.					
	•					
342	357.1					
379	45					
	45 46					
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
Interferen Sear	næ ch	4/14/06	DCL			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST Search updated (EPO, JPO, DERWENT  Inventor Name Search (Check for double patenting)		DCL			